TABLE I. The	. The EFG/strain tensor for NaCl.		
	<sup>S</sup> 11 (a.u.)	S <sub>44</sub> (a.u.)	
Calculated Experiment <sup>a, b</sup>	+0.85 $0.82 \pm 0.12$	- 0.43 0.34 ± 0.03	

<sup>a</sup>See Ref. 7.

<sup>b</sup>The signs of  $S_{11}$  and  $S_{44}$  were not determined experimentally, but were assumed to be opposite.

ion wave functions. This is probably the first calculation of an EFG in any solid that has not required the use of any Sternheimer shielding factors. The method can be applied to other solids and complex molecules and to other hyperfine interactions. Further studies are needed to determine the limits of validity of the model and to consider possible refinements in the case of more covalent solids.

The author wishes to thank the staff of the Queen's University Computing Centre for their help, and C. Hodges for his comments on the manuscript.

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## X-Ray Photoemission Spectra of Crystalline and Amorphous Si and Ge Valence Bands\*

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> High-resolution x-ray photoelectron spectra of the total valence bands of crystalline and amorphous silicon and germanium are reported. For the crystals, the spectra yield results that are strikingly similar to current theoretical calculations of the electron density of states,  $\rho(E)$ . Amorphous Si and Ge exhibit definite band structures that are similar to one another but markedly different from the crystalline results. They agree very well with the theoretical model of Joannopoulos and Cohen.

Although several density-of-states calculations have been carried out on silicon<sup>1</sup> and germanium,<sup>2</sup> relatively little experimental information is as yet available concerning the densities of states  $\rho(E)$  of the more tightly bound valence electrons of these semiconductors. The valence-band densities of states of the crystalline modifications of Si and Ge are of current and continuing interest. In addition, a considerable amount of recent activity has been directed toward elucidating the electronic structure in the amorphous forms.<sup>3</sup> Thorpe and Weaire<sup>4</sup> have discussed three alternative models for the densities of states of amorphous Si and Ge, and Joannopoulos and Cohen<sup>5</sup> have recently given quantitative predictions for  $\rho(E)$ . In this Letter we present the first highresolution x-ray photoelectron (XPS) spectra for the densities of states of crystalline and amor-



FIG. 1. XPS valence-band spectra of crystalline and amorphous Si and Ge.

phous Si and Ge and compare these spectra with theory.

The crystalline samples were cleaved in a dry inert atmosphere from  $20-\Omega$  cm *n*-type silicon and intrinsic Ge single crystals. The spectra were taken with a Hewlett Packard HP5950A photoelectron spectrometer with monochromatic Al  $K\alpha$  x rays. After cleaving, the samples were introduced into the analyzer vacuum of  $8 \times 10^{-9}$  Torr within 30 sec. The intensity ratios of the Si(2p)to the contaminant O(1s) and C(1s) lines were 5:1 and 12:1, respectively. No oxygen contamination was detected on the Ge sample, whereas the intensity ratio of Ge(3p) to C(1s) was 10:1. To prepare amorphous specimens, Si and Ge films were evaporated onto clean gold surfaces at room temperature in the spectrometer sample preparation chamber. The background pressure was initially  $4 \times 10^{-7}$  Torr; it rose to  $3 \times 10^{-6}$  Torr for 4 min during the evaporations. The films were then directly transferred to the analyzer vacuum of  $8 \times 10^{-9}$  Torr. The only contaminant detected was oxygen on the Si film [Si(2p):O(1s) = 7:1]. The raw data for the valence-band regions of all four specimens are shown in Fig. 1. The spectra are referenced to the Fermi level  $E_F$  of a thin layer of Au evaporated, after the valence-band measurement, onto the semiconductor surfaces. The Au 4f lines are used as a secondary standard, by assuming that their binding energies are the same relative to  $E_{\rm F}$  in the evaporated film and in bulk gold. The densities of states of the semiconductors extend ~15 eV below  $E_F$  in both Si and Ge. The structure at the foot of the unresolved Ge 3d doublet can be entirely assigned to the first characteristic energy-loss structure of the valence-band photoelectrons, as can most of the satellite structure that is found at 17 eV below



FIG. 2. Si 2p and Ge 3d core levels exhibiting the characteristic energy-loss structure (plasmons) used in the valence-band correction procedure.

the valence-band peaks in Si. The energy-loss spectra from typical core levels are shown in Fig. 2. To correct for energy losses, the inelastic loss spectrum was approximated by the sum of a continuous tail with magnitude at each point proportional to the spectrum area at lower bind-



FIG. 3. Point plots, corrected spectra I'(E); lower curves, calculated (Refs. 1c, 2b, and 5) densities of states  $\rho(E)$  for the valence bands of crystalline and amorphous (ST-12) Si and Ge; middle curves, broadened  $\rho(E)$  spectra for crystalline Si and Ge.

ing energy plus a discrete loss structure constructed by folding a response function determined from the discrete inelastic structure of a sharp core peak and the valence-band structure. This correction accounted for the structure at 19 eV in Ge and for 95% of the structure at 23 eV in Si. The remaining 5% is accounted for by the contaminant oxygen 2s peak. A correspondingly small portion of the peak at 6.6 eV can be attributed to the O(2p) line. The corrected valenceband spectra are shown in Fig. 3.

Several band-structure calculations have predicted  $\rho(E)$  for crystalline Si and Ge. These calculations show very good agreement among themselves. They yield three characteristic peaks in  $\rho(E)$ . We shall label these peaks according to the symmetry points  $X_4$ ,  $L_1$ , and  $L_2'$ , in order of increasing binding energy. Of course the peaks do not arise entirely from bands at these symmetry points. This notation is used only for identification. To facilitate comparison with experiment we have plotted (Fig. 3) for Si and Ge both  $\rho(E)$  as calculated<sup>1c,2b</sup> and a broadened version that is consistent with the experimental resolution.

The agreement between theoretical and experimental peak positions and shapes is striking for crystalline Si and Ge. Table I lists the energies of the characteristic features, the theoretical

TABLE I. Energies of characteristic features in the valence-band spectra of Si and Ge. The theoretical entries are taken from density of states calculations after appropriate broadening.

	Crystalline silicon					
	Experiment <sup>a</sup> Theory <sup>b</sup>					
	I' (E) (eV)	EPM (Cohen <sup>C</sup> ) (eV)		SCOPW (Stukel <sup>d</sup> ) (eV)		
x <sub>4</sub>	2.2	2.6		2.5		
W <sub>2</sub>	3.6	4.0		3.1		
v <sup>e</sup>	4.4	5.1		4.5		
L <sub>1</sub>	6.6	7.1		6.9		
w <sub>1</sub>	7.8	8.2		8.2		
L'2	9.2	10.0		9.6		
г <sub>1</sub>	14.7	13.0		11.8		
	Crystalline germanium					
	Experiment <sup>a</sup>	ment <sup>a</sup> Theory <sup>b</sup>				
	I' (E) (eV)	EPM (Cohen <sup>f</sup> ) (eV)	OPW (Herman <sup>g</sup> ) (eV)	SCOPW (Stukel <sup>d</sup> ) (eV)		
x <sub>4</sub>	2.4	2.3	2.7	2.6		
w <sub>2</sub>	3.6	3.4	3.8	3.6		
v <sup>e</sup>	4.9	4.4	4.9	4.9		
L <sub>1</sub>	7.2	6.9	7.3	6.8		
w <sub>1</sub>	8.6	8.5	8.6	7.8		
L'2	10.3	9.7	10.2	9.4		
г <sub>1</sub>	13.0	12.4	12.7	11.7		

<sup>a</sup> Positions relative to gold Fermi level.

<sup>b</sup>Positions relative to the top of the valence bands.

<sup>c</sup>See Ref. 1c.

<sup>d</sup>See Ref. 1b.

<sup>e</sup> The valley between  $W_2$  and  $L_1$  is arbitrarily called V.

<sup>f</sup>See Ref. 2b.

<sup>g</sup>See Ref. 2a.

densities of states  $\rho(E)$ , and the corrected XPS spectra, which we denote as I'(E). The marginal ability to locate the feature  $W_2$  gives an indication of the resolving power of our spectrometer. As Table I shows, I'(E) provides very strong confirmation of all three theoretical methods for calculating  $\rho(E)$ . The relative intensities of the *p*-like  $X_4$  and the *s*-like  $L_1 + L_2'$  peaks in I'(E) vary markedly between Si and Ge and in neither case agree with p(E). This is not unexpected, since I'(E) resembles  $\rho(E)$  weighted with the photoemission cross section  $\sigma$ . Extrapolating measured 3s/3pand 4s/4p core-level intensity ratios<sup>6</sup> to the valence electrons of Si and Ge yields

$$[\sigma(3s)/\sigma(3p)]_{si}:[\sigma(4s)/\sigma(4p)]_{Ge} = 2.3:1.$$

The observed change in the intensity ratio of the corresponding valence-band structures is 2.2:1. Our Si intensities agree well with earlier XPS<sup>7</sup> and Si  $L_{2,3}$  [soft x-ray emission spectroscopy (SXS)] results.<sup>8</sup>

The excellent agreement observed for crystalline Si and Ge provides a firm basis for further XPS and theoretical band-structure work on semiconductors. It also suggests that these two approaches may profitably be used together.

The results for amorphous Si and Ge are significantly different from the respective crystalline modifications. From the I'(E) spectra (Fig. 3) we note the following observations: (1) The gross variation of intensity with respect to energy is similar for the amorphous and crystalline materials in both elements. (2) The " $X_4$ " peak remains essentially intact from crystalline to amorphous material. (3) The  $L_1$  and  $L_2'$  peaks merge into a single broad peak of intermediate energy. (4) I'(E) shows a distinct minimum between the " $X_4$ " peak and the broader peak in the amorphous materials. (5) The centroid of the " $X_4$ " peak shifts toward  $E_{\rm F}$  in each case, by 0.4 eV in Si and 0.5 eV in Ge. (6) The amorphous Ge spectra were in good agreement for samples prepared by evaporation and by Ar<sup>+</sup> ion bombardment (1000 eV, 10  $\mu$ A for 1 h).

Observations (1)-(3) are in agreement with the Si  $L_{2,3}$  (SXS) results of Wiech and Zöpf.<sup>8</sup> Observation (2) is expected because  $X_4$  arises from localized *p*-like bonding orbitals,<sup>9</sup> which are relatively insensitive to long-range order. Observation (5) is in qualitative agreement with earlier uvphotoemission work.<sup>3a</sup> Pierce and Spicer<sup>3c</sup> have recently emphasized the sensitivity of uv photoemission spectra to the method of sample preparation, but observation (6) indicates that I'(E) for amorphous Ge was reproducible even though the method of sample preparation was varied.

Observations (3)-(5) are the ones that allow a distinction to be made among different theoretical models for amorphous semiconductors.

Thorpe and Weaire<sup>4</sup> have recently discussed three theoretical models for amorphous Si and Ge. The Brust model<sup>10</sup> yields a  $\rho(E)$  spectrum. Thorpe and Weaire indicated that the Penn model<sup>11</sup> might apply to amorphous semiconductors. The  $\rho(E)$  curve for the Penn model shows no minimum, but rather a (broadened) logarithmic divergence near  $E_F$  and a free-electron  $\rho(E)$  below. Our data exclude both of these shapes for  $\rho(E)$ , thereby ruling out these two models as being applicable to amorphous Si and Ge. Our spectra definitely require a model that predicts large changes in the s-like  $L_1$  and  $L_2'$  peaks but not in the p-like  $X_4$  peak on going from the crystalline to the amorphous state. Thorpe and Weaire described a model that distinguished between the effects of local and long-range interactions. They sketched a curve for  $\rho(E)$  that is in good agreement with our amorphous Si and Ge spectra, especially observations (2)-(4).

A more quantitative comparison with theory is provided by the recent empirical-pseudopotential calculations of Joannopoulos and Cohen<sup>5</sup> on several forms of Ge. Their  $\rho(E)$  results for Ge (ST-12), after smoothing to eliminate sharp features associated with long-range order, show very good agreement with our I'(E) curve. They have also calculated Si (ST-12) with similar results. Their  $\rho(E)$  curves are shown in Fig. 3. As they pointed out, Ge (ST-12) shows short-range disorder, but the peak near  $E_{\rm F}$  still arises from *p*-like bonding orbitals. Their model predicts the shift of this peak toward  $E_F$  [observation (5)]. The crucial feature of the ST-12 structure, according to Joannopoulos and Cohen, is the presence of five- and seven-membered rings. This feature causes the two lower-energy peaks in I'(E) to merge.

In summary, our I'(E) results strongly support the Joannopoulos-Cohen model for amorphous Si and Ge. It appears that future theoretical developments on the band structure of amorphous Si and Ge should be constrained to reproduce the first five observations listed above.

It is a pleasure to acknowledge the generous contributions of Professor Marvin Cohen and Mr. John Joannopoulos to this research. One of us (L.L.) greatly appreciates a grant from the VOLUME 29, NUMBER 16

Max-Kade Foundation.

\*Work performed under the auspices of the U.S. Atomic Energy Commission.

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## Measurement of Acoustic-Wave Dispersion in Solids

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By measuring the time of flight of heat pulses using superconducting tunnel junctions, we have obtained the frequency dependence of the energy velocity of acoustic waves in indium antimonide. This yields, with good accuracy, the dispersion relations for long wavelengths.

Dispersion of acoustic waves in a perfect lattice arises from the discreteness of the crystalline array, and becomes important for wavelengths comparable to the dimension of the unit cell.<sup>1</sup> The frequency versus wave-vector relations ( $\nu$  versus q) can, in general, be obtained from neutron or x-ray scattering data; however, the frequency dependence of the acoustic velocity has not been observed directly in a solid. We present here the measurement of group-velocity dispersion in indium antimonide by means of heat pulses at liquid-helium temperatures.

Acoustic phonons, having energies of a few Kelvin  $(10^{11} \text{ to } 10^{12} \text{ Hz})$ , can be generated in a crystal by Joule heating of a metallic film evaporated on the surface. The phonons, thus produced in a wide spectrum, propagate ballistically and

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reach the crystal boundary-each with its own velocity. If the film is excited with a current impulse, the front edge of the heat pulse will signal the arrival of those phonons that have the largest group velocity, and this usually corresponds to the lowest frequency, while later times will correspond to the arrival of dispersed phonons. The available detectors are quadratic and are mainly of two kinds: (i) superconducting bolometers,<sup>2</sup> sensitive to the energy flux irrespective of the frequency content of the heat pulse, and (ii) superconductor-barrier-superconductor tunnel junctions,<sup>3</sup> which are only sensitive to the phonons able to break the Cooper pairs. Therefore, they have a threshold of detection equal to the superconducting energy gap  $2\Delta$ , which usually stands inside the spectrum emitted by the metallic film.